

• General Description

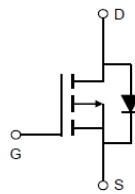
The CH30P03A combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$. This device is ideal for load switch and battery protection applications.

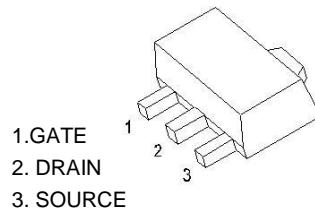
• Features

- Advance high cell density Trench technology
- Low $R_{DS(ON)}$ to minimize conductive loss
- Low Gate Charge for fast switching
- Low Thermal resistance

• Application

- MB/VGA Vcore
- SMPS 2nd Synchronous Rectifier
- POL application
- BLDC Motor driver

• Product Summary

 $V_{DS} = -30V$
 $R_{DS(ON)} = 23m\Omega$
 $I_D = -20A$

SOT-89-3L

• Ordering Information:

Part NO.	CH30P03A
Marking	CH30P03A
Packing Information	REEL TAPE
Basic ordering unit (pcs)	1000

• Absolute Maximum Ratings ($T_c = 25^\circ C$)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V_{DS}	-30	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current	$I_D @ T_c = 25^\circ C$	-20	A
	$I_D @ T_c = 75^\circ C$	-10.5	A
	$I_D @ T_c = 100^\circ C$	-9	A
	$I_D @ T_A = 25^\circ C$	-11.2	A
	$I_D @ T_A = 75^\circ C$	-8.5	A
Pulsed Drain Current ^①	I_{DM}	-38	A
Total Power Dissipation ^②	$P_D @ T_c = 25^\circ C$	9	W
Total Power Dissipation	$P_D @ T_c = 100^\circ C$	2.0	W
Operating Junction Temperature	T_J	-55 to 150	°C
Storage Temperature	T_{STG}	-55 to 150	°C

Single Pulse Avalanche Energy	E _{AS}	58	mJ
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•Thermal resistance

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction - case ^②	R _{thJC}	-	-	7.1	°C/W
Thermal resistance, junction - ambient	R _{thJA}	-	-	140	°C/W
Soldering temperature, wavesoldering for 10s	T _{sold}	-	-	265	°C

•Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =-250uA	-30			V
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} =V _{DS} , I _D =-250uA	-1.2		-2.5	V
Drain-Source Leakage Current	I _{DSS}	V _{DS} =-30V, V _{GS} =0V			-1.0	uA
Gate- Source Leakage Current	I _{GSS}	V _{GS} =±20V, V _{DS} =0V			±100	nA
Static Drain-source On Resistance	R _{DS(ON)}	V _{GS} =-10V, I _D =-10A		23	30	mΩ
		V _{GS} =-4.5V, I _D =-10A		28	38	mΩ
Forward Transconductance	g _{FS}	V _{DS} =-10V, I _D =-5A		9		s
Source-drain voltage	V _{SD}	I _S =-20A			1.20	V

•Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Input capacitance	C _{iss}	f = 1MHz	-	1135	-	pF
Output capacitance	C _{oss}		-	184	-	
Reverse transfer capacitance	C _{rss}		-	117	-	

•Gate Charge characteristics(T_a = 25°C)

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Total gate charge	Q _g	V _{DD} =15V I _D = 7.5A V _{GS} = 10V	-	21	-	nC
Gate - Source charge	Q _{gs}		-	1.4	-	
Gate - Drain charge	Q _{gd}		-	4.1	-	

Note: ① Pulse Test : Pulse width ≤ 300μs, Duty cycle ≤ 2% ;

Typical Electrical And Thermal Characteristics (Curves)

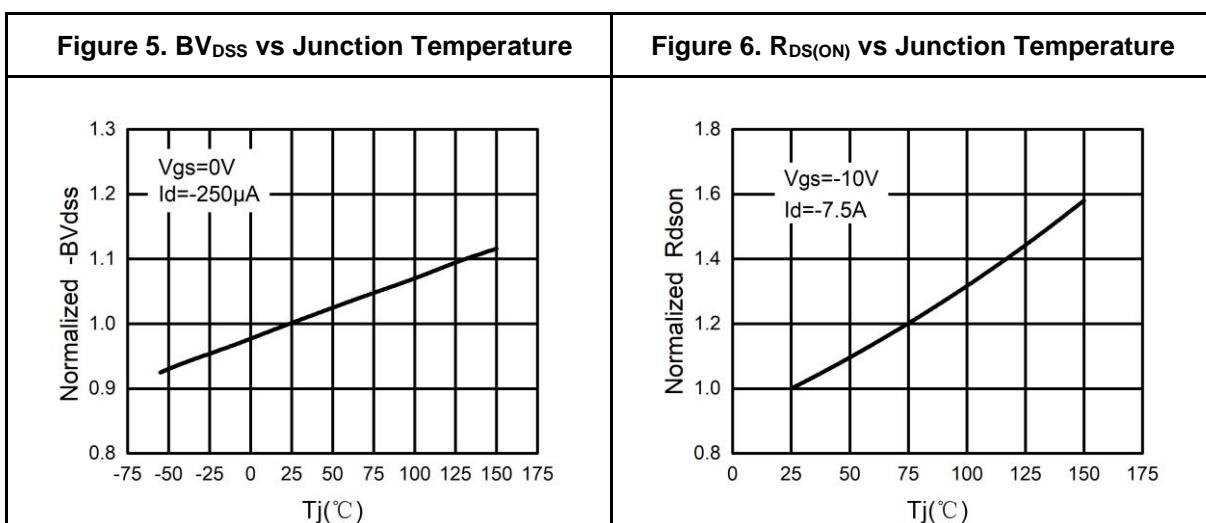
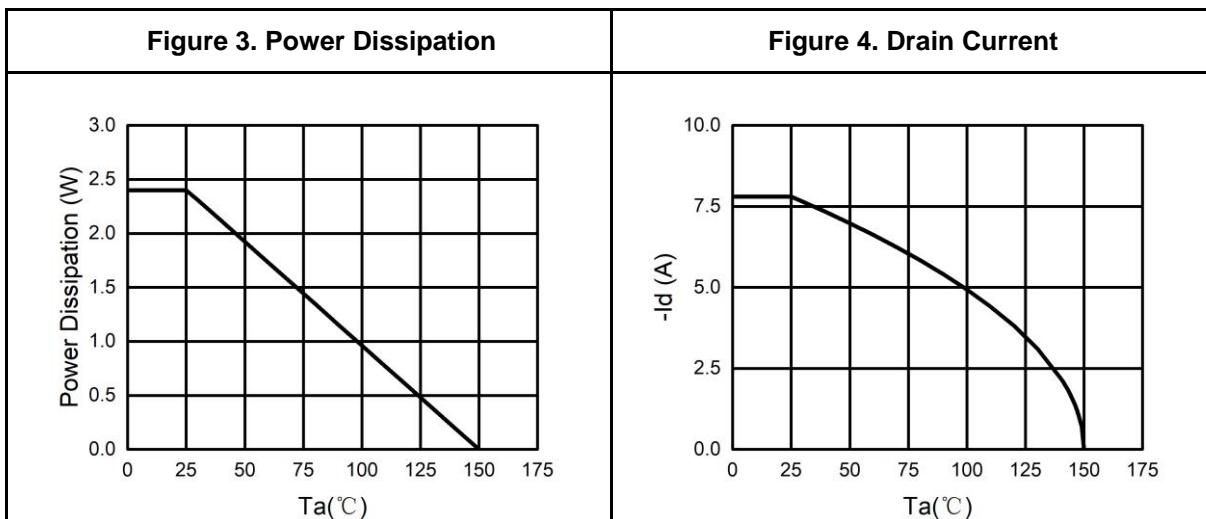
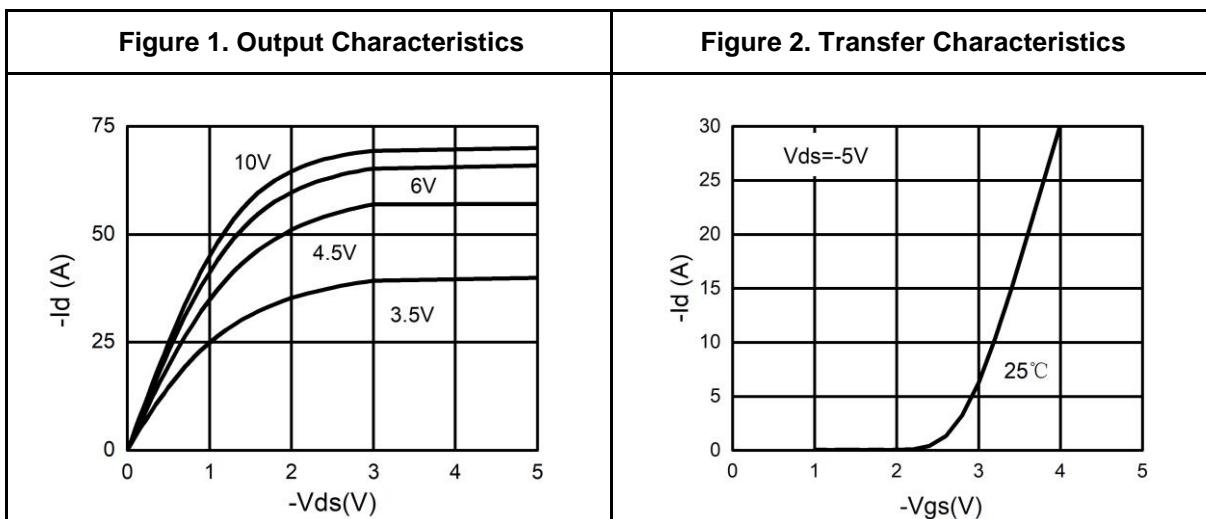
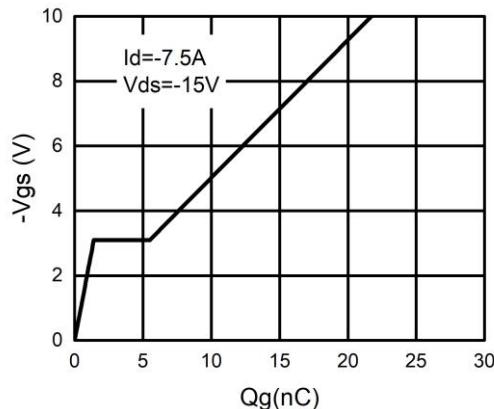
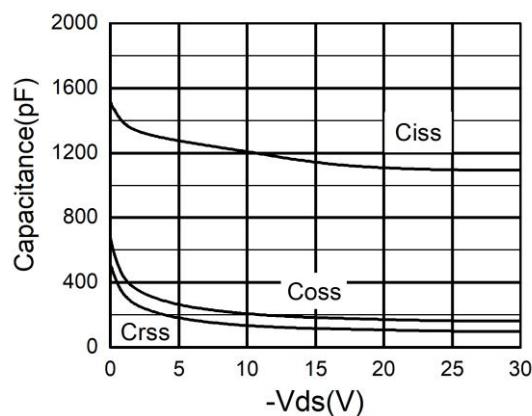
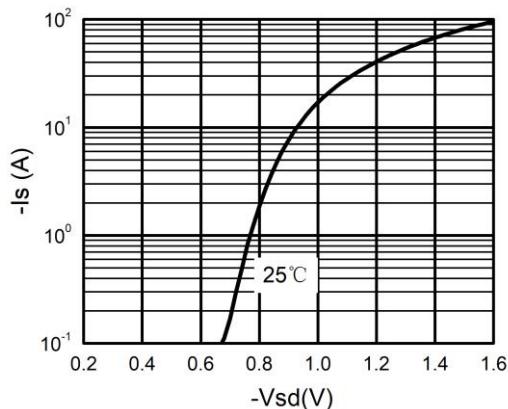
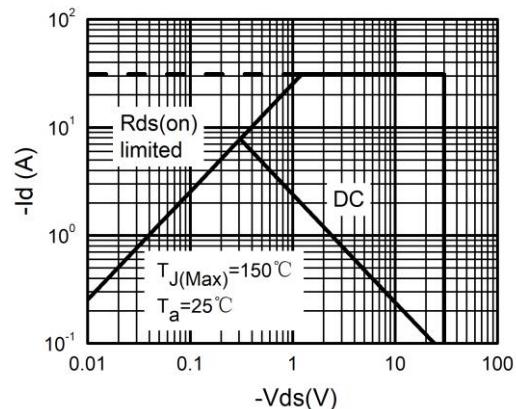
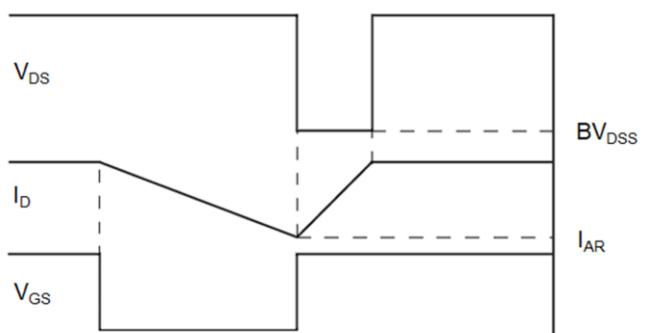
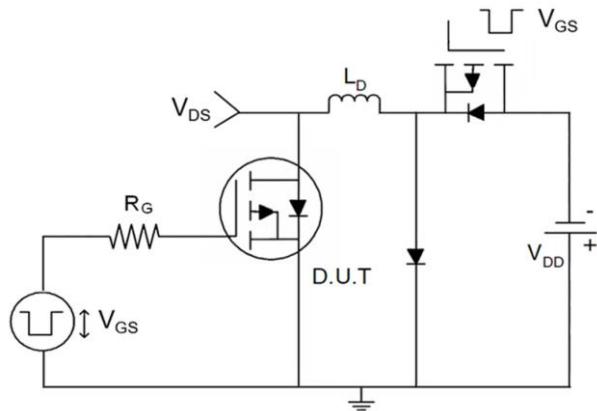


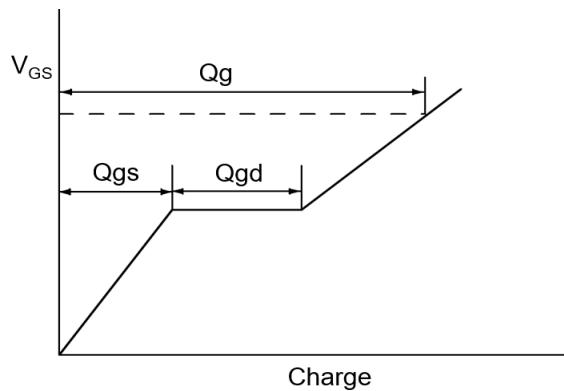
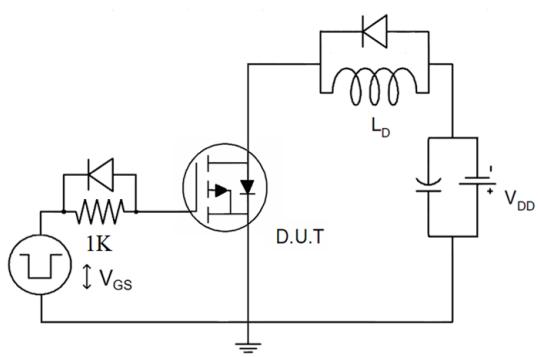
Figure 7. Gate Charge Waveforms

Figure 8. Capacitance

Figure 9. Body-Diode Characteristics

Figure 10. Maximum Safe Operating Area


Test Circuit

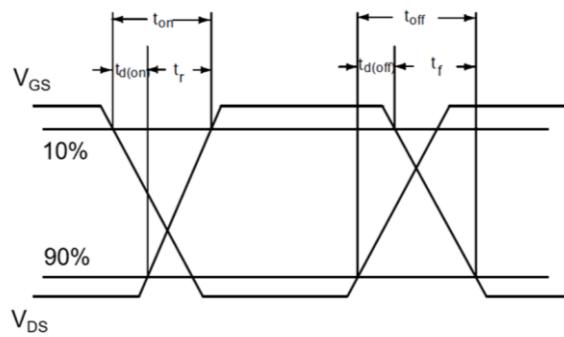
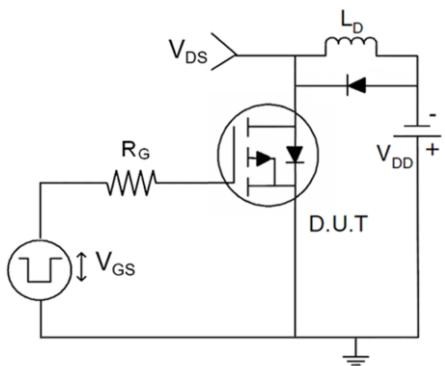
1) E_{AS} Test Circuits

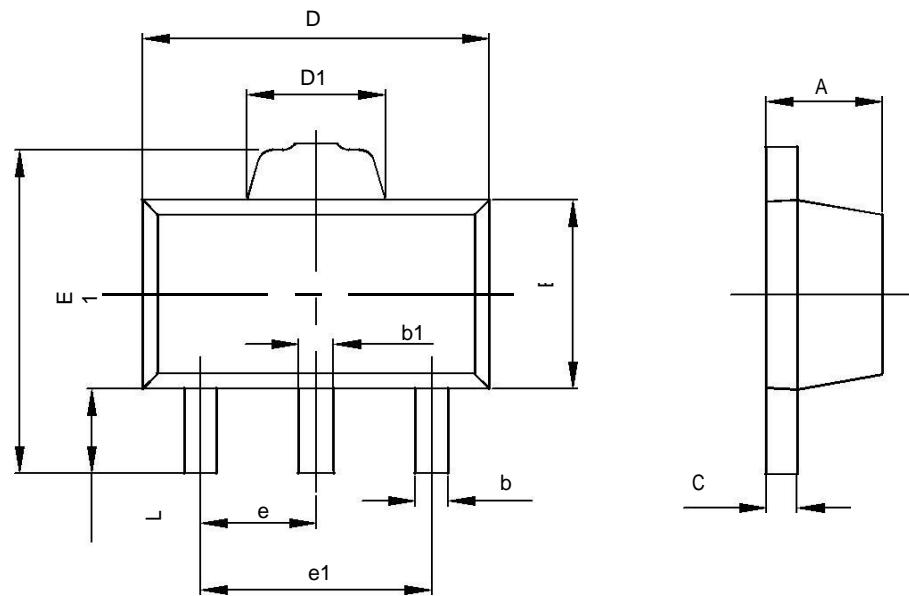


2) Gate Charge Test Circuit



3) Switch Time Test Circuit



SOT-89-3L PACKAGE OUTLINE DIMENSIONS


Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	1.400	1.600	0.055	0.063
b	0.320	0.520	0.013	0.020
b1	0.360	0.560	0.014	0.022
c	0.350	0.440	0.014	0.017
D	4.400	4.600	0.173	0.181
D1	1.400	1.800	0.055	0.071
E	2.300	2.600	0.091	0.102
E1	3.940	4.250	0.155	0.167
e	1.500TYP		0.060TYP	
e1	2.900	3.100	0.114	0.122
L	0.900	1.100	0.035	0.043